

Magnetic Neutron Reflectometry

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Outline

- Scattering processes
- Reflectivity of a slab of material
- Magnetic scattering
- Off-specular scattering
- Source parameters
- Comparison with x-rays

Neutrons are waves

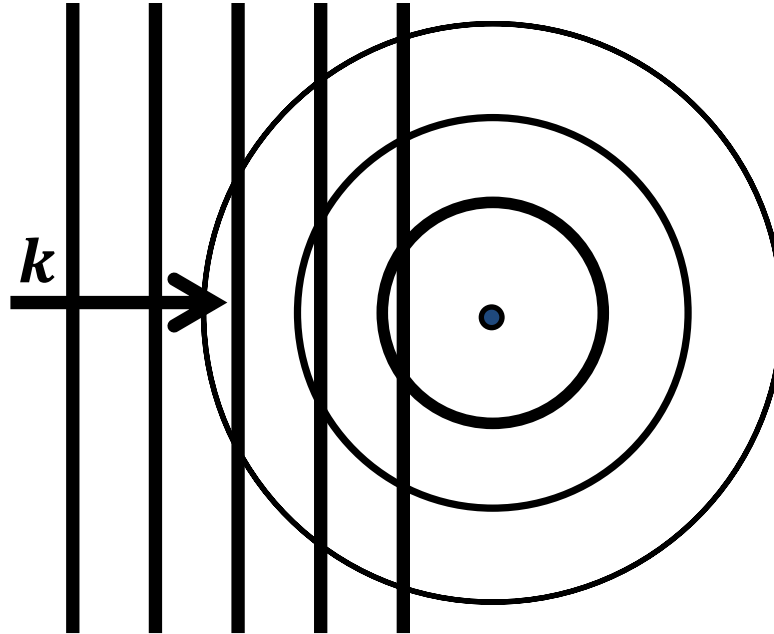
- de Broglie wavelength: $\lambda = \frac{h}{p} = \frac{h}{mv}$

– Example: $\lambda = 2\text{\AA}$, $v = 1978 \frac{m}{s}$,

$$E = \frac{mv^2}{2} = 20.5 \text{ meV}$$

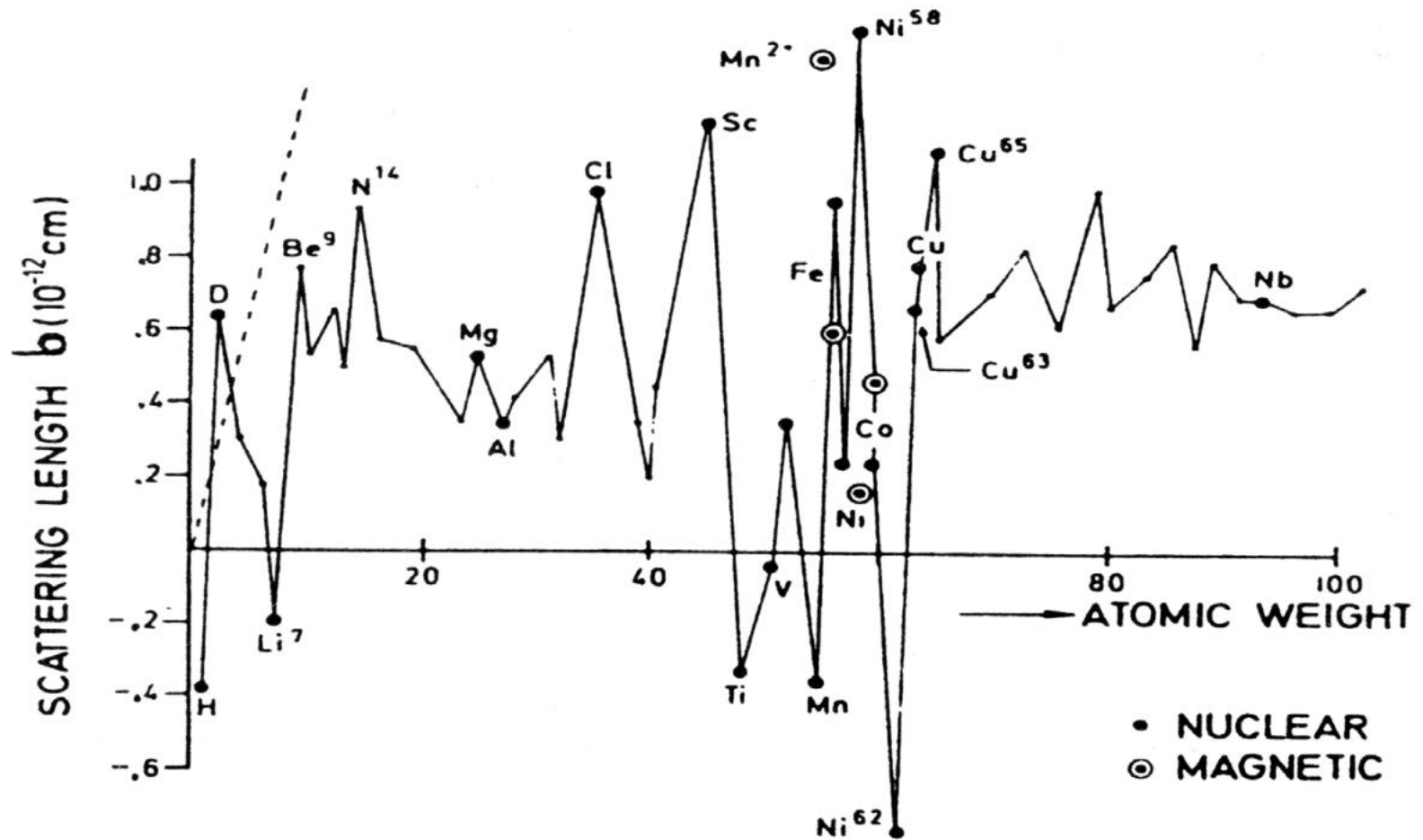
- Plane wave: $\psi \sim e^{ik \cdot r}$, $k = \frac{2\pi}{\lambda}$

Scattering from a single fixed nucleus



- Incident plane wave: $\psi \sim e^{ikx}$
- Potential from nucleus: $V(\mathbf{r}) = \frac{2\pi\hbar^2}{m} b \delta(\mathbf{r})$
- Outgoing spherical wave $\psi \sim -\frac{b}{r} e^{ikr}$
- Differential cross section: $\frac{d\sigma}{d\Omega} = b^2$, b = scattering length

Intrinsic Cross Section: Neutrons



Reflectometry: Neutrons in media

- Neutrons incident on a slab of material at grazing angle
- Average scattering length density:

$$\rho = \sum_i N_i b_i$$

- Neutrons sample average in-plane density

$$\rho(z) = \langle \rho(x, y, z) \rangle_{xy}$$

- Elastic scattering

- Energy in vacuum: $E = \frac{\hbar^2 k_0^2}{2m}$

- Energy in medium: $E = \frac{\hbar^2 k^2}{2m} + V = \frac{\hbar^2}{2m} (k^2 - 4\pi\rho)$

- Index of refraction:

$$n = \frac{k}{k_0} = 1 - \frac{4\pi}{k_0^2} \rho = 1 - \frac{\lambda_0^2}{2\pi} \rho$$

- ρ is typically on the order of 10^{-6}\AA^{-2}

Fresnel Reflectivity

- Specular reflection:

$$\alpha_r = \alpha_i$$

$$Q = 2k_{iz}\hat{z} = \frac{4\pi}{\lambda} \sin(\alpha_i)\hat{z}$$

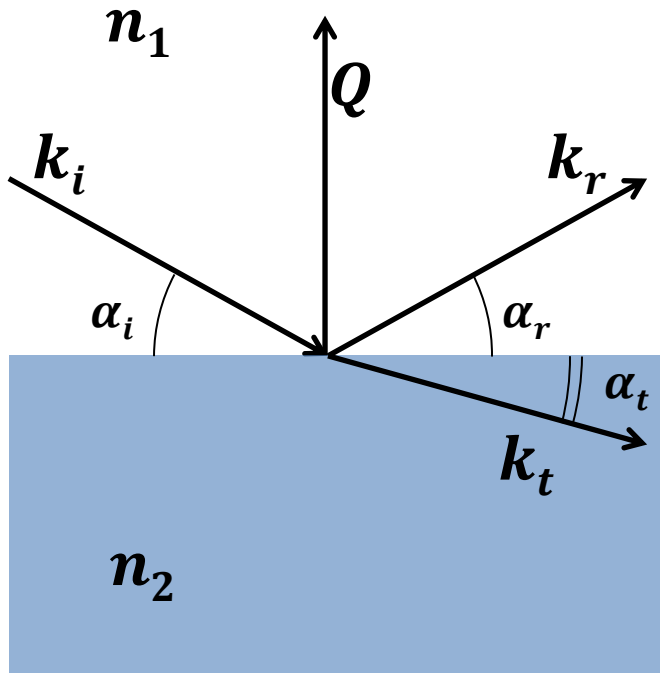
- Reflection coefficient: ratio of reflected amplitude to incident amplitude

$$r = \frac{k_{iz} - k_{tz}}{k_{iz} + k_{tz}} = \frac{1 - \sqrt{1 - \left(\frac{Q_c}{Q}\right)^2}}{1 + \sqrt{1 - \left(\frac{Q_c}{Q}\right)^2}}$$

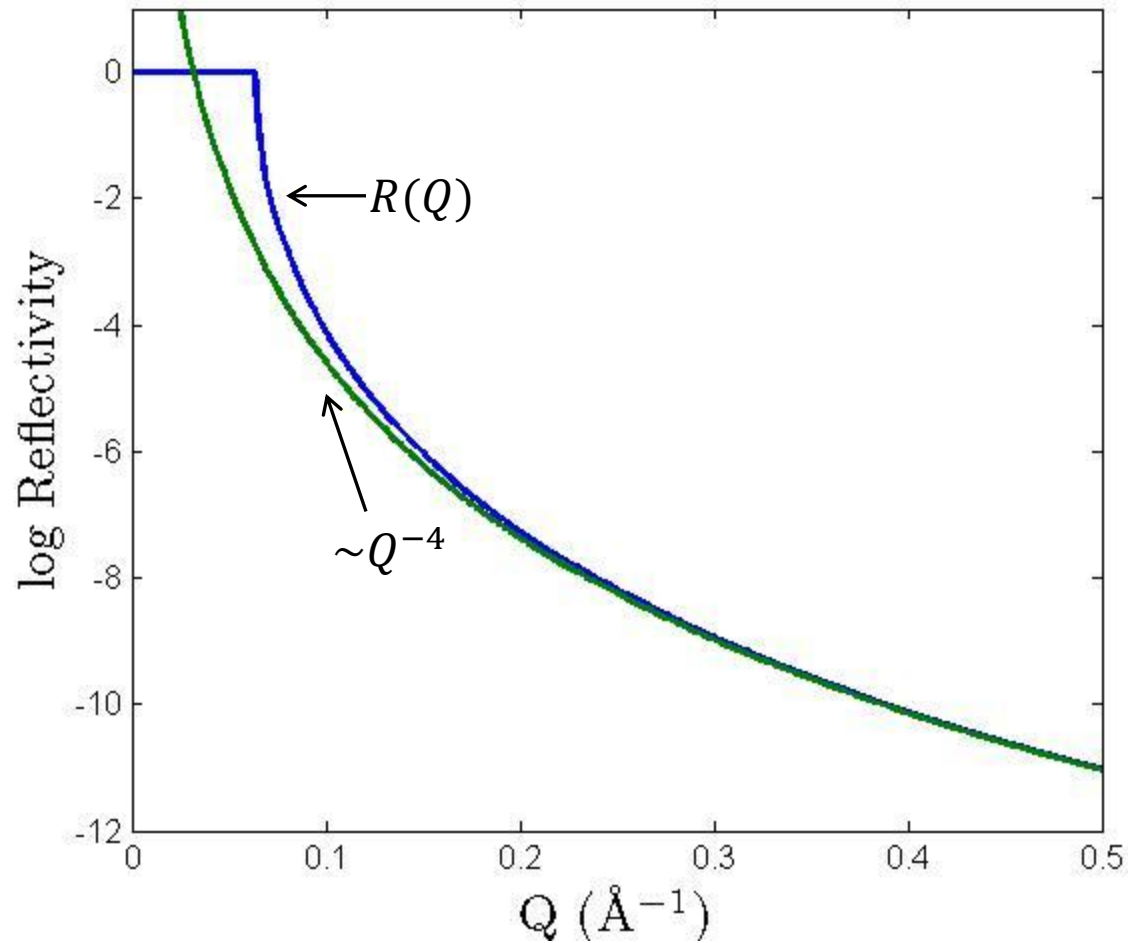
- Reflectivity:

$$R = |r|^2 \approx \left(\frac{Q_c}{2Q}\right)^4 \text{ for } Q \gg Q_c$$

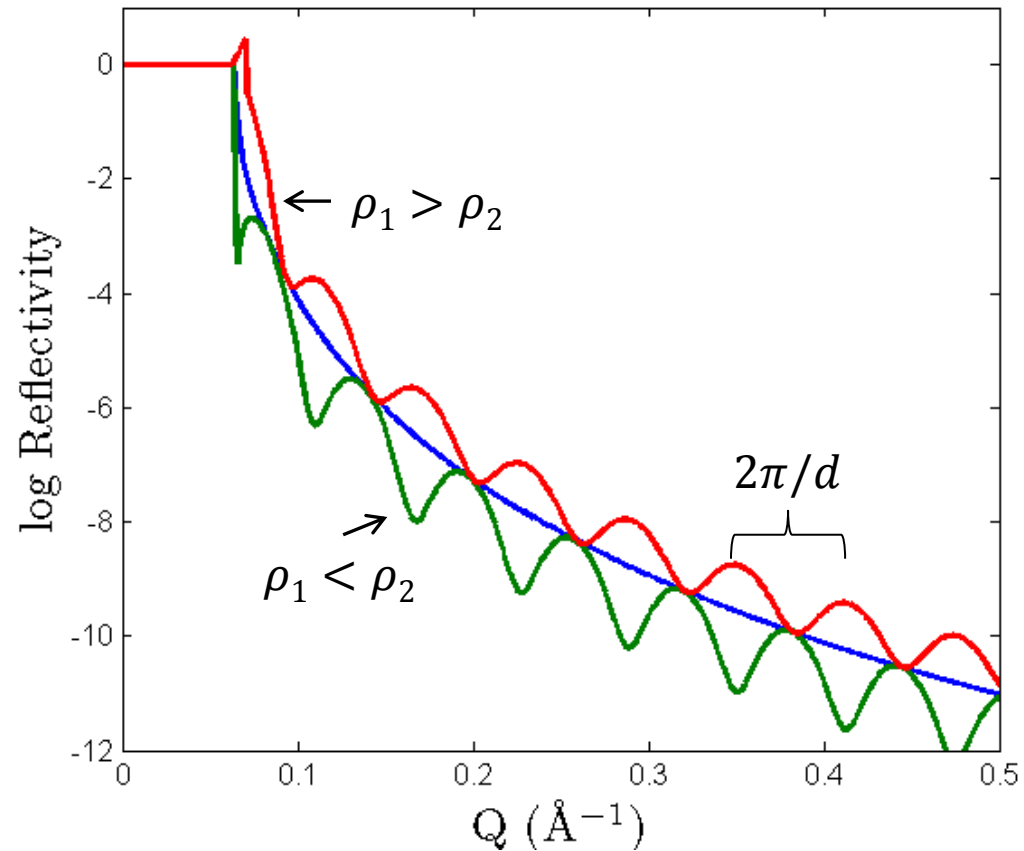
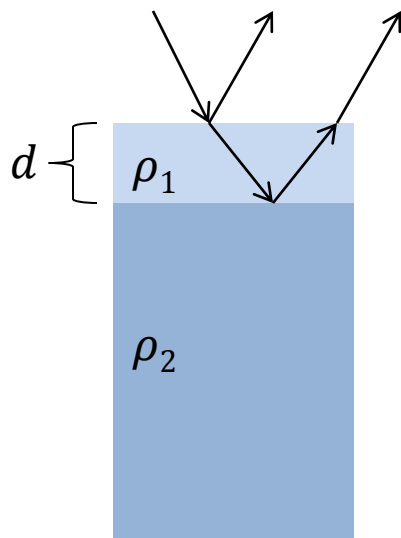
$$Q_c^2 = 16\pi\rho$$



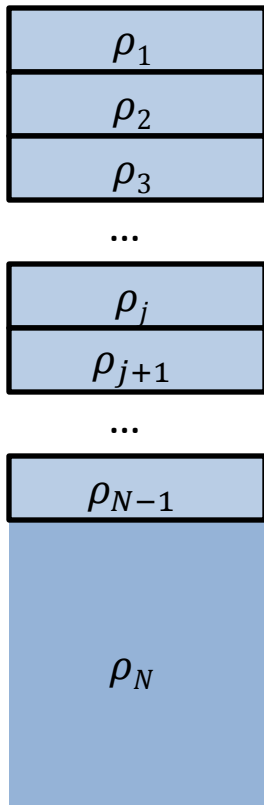
Fresnel Reflectivity



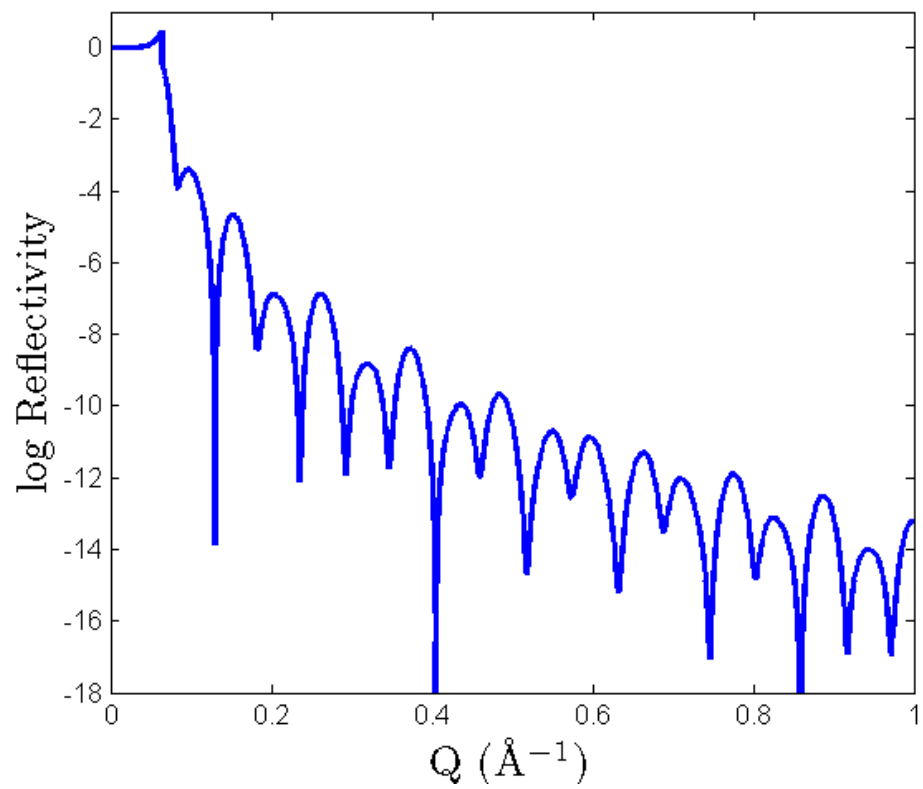
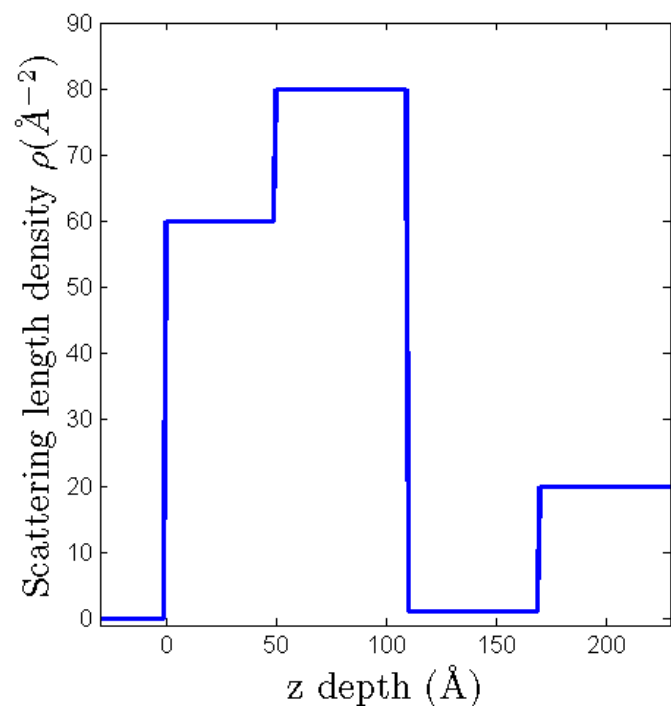
Thin film on a substrate: Kiessig fringes



Multilayer: Parratt formula



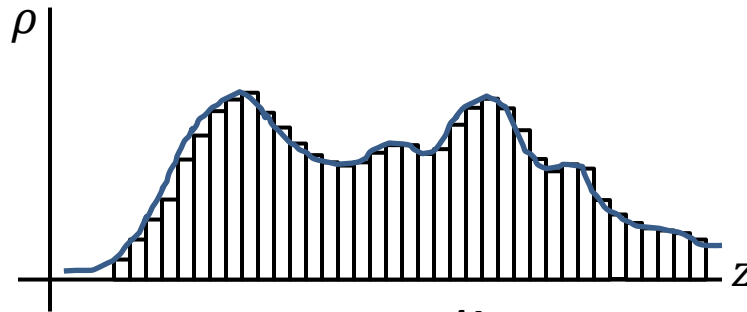
- Net reflectivity at the surface can be calculated *exactly* by enforcing continuity at each interface
- Dynamical: accounts for transmission and reflection at each interface



Reflectivity from an arbitrary $\rho(z)$

- Divide up $\rho(z)$ into slices of constant ρ and apply Parratt formula

– e.g.



- Or: apply Born approx. (kinematical treatment)

$$r(Q) \approx \frac{4\pi}{iQ} \int_{-\infty}^{\infty} \rho(z) e^{iQz} dz$$

- Assumes scattering is weak. Fails near Q_c where reflectivity approaches unity (strong scattering)

Inverting Reflectivity Data

- How do you get $\rho(z)$ from $R(Q)$?
 - Start with a good model and refine parameters
 - Inverse Fourier transform: phase can be recovered by adding reference layers of known density to the front & back of the film (Majkrzak 1995)

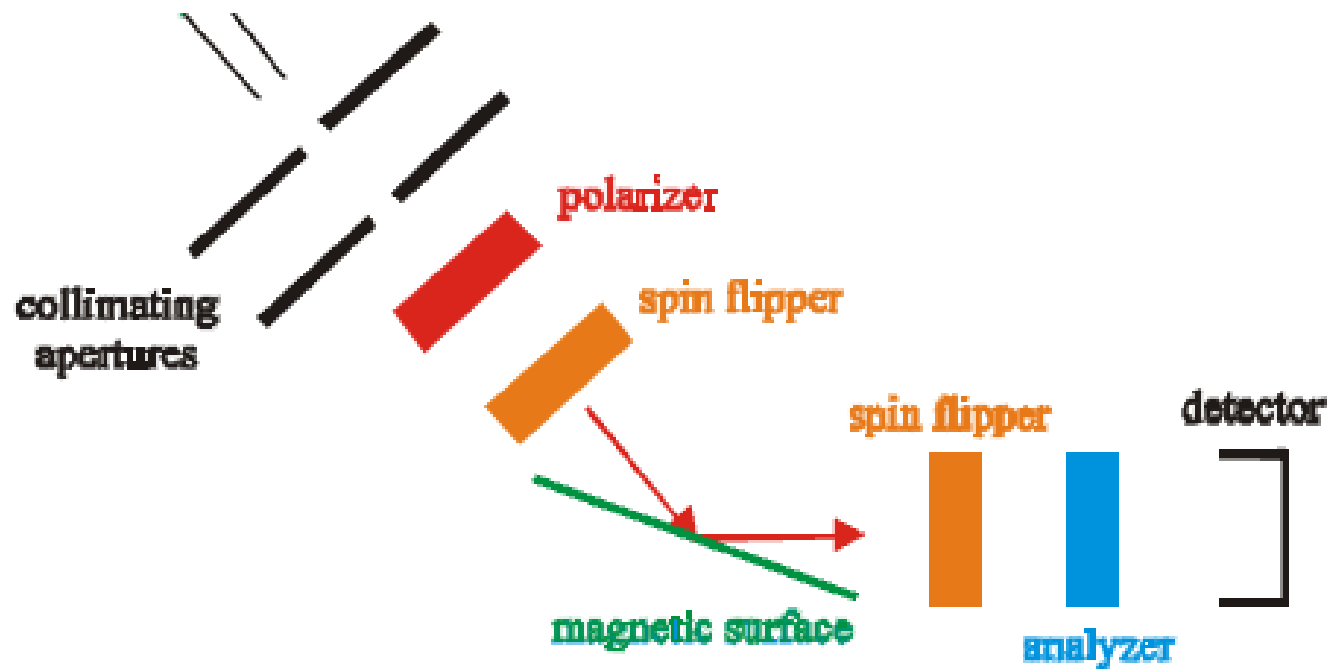
Magnetic reflectometry

- A magnetic field adds a spin-dependent potential to the Schrödinger equation

$$V_m = -\boldsymbol{\mu} \cdot \boldsymbol{B} = -\mu \boldsymbol{\sigma} \cdot \boldsymbol{B}$$

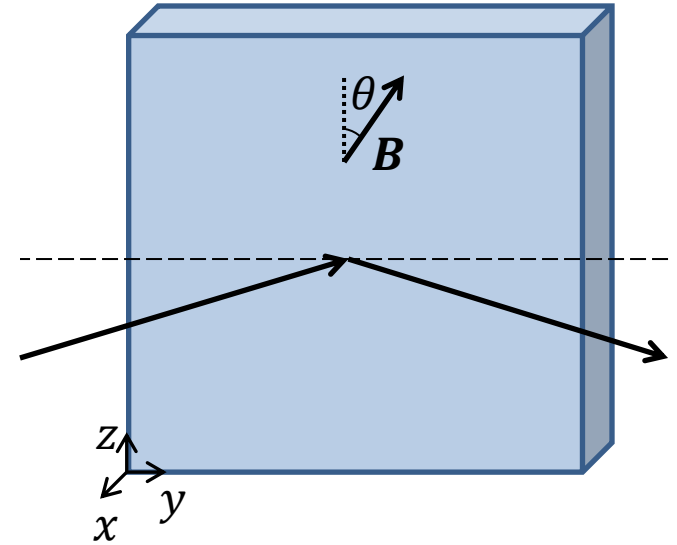
- μ is the neutron magnetic moment
 - $\boldsymbol{\sigma}$ has the Pauli spin matrices as components
- We now have to treat the incoming plane wave as a spinor: $\psi = \begin{pmatrix} \psi_+ \\ \psi_- \end{pmatrix}$
 - Polarizers and analyzers allow control of which spin hits the sample as well as which spin is detected

SNS BL4a Schematic



Magnetic reflectometry

- Let z be the spin quantization axis, and let x lie along \mathbf{Q}
- Only the components of \mathbf{B} perpendicular to \mathbf{Q} contribute to scattering



- This gives rise to a set of coupled Schrödinger equations for ψ_+ and ψ_-

$$[\partial_x^2 + k_{0x}^2 - 4\pi\rho_{++}]\psi_+ - 4\pi\rho_{+-}\psi_- = 0$$

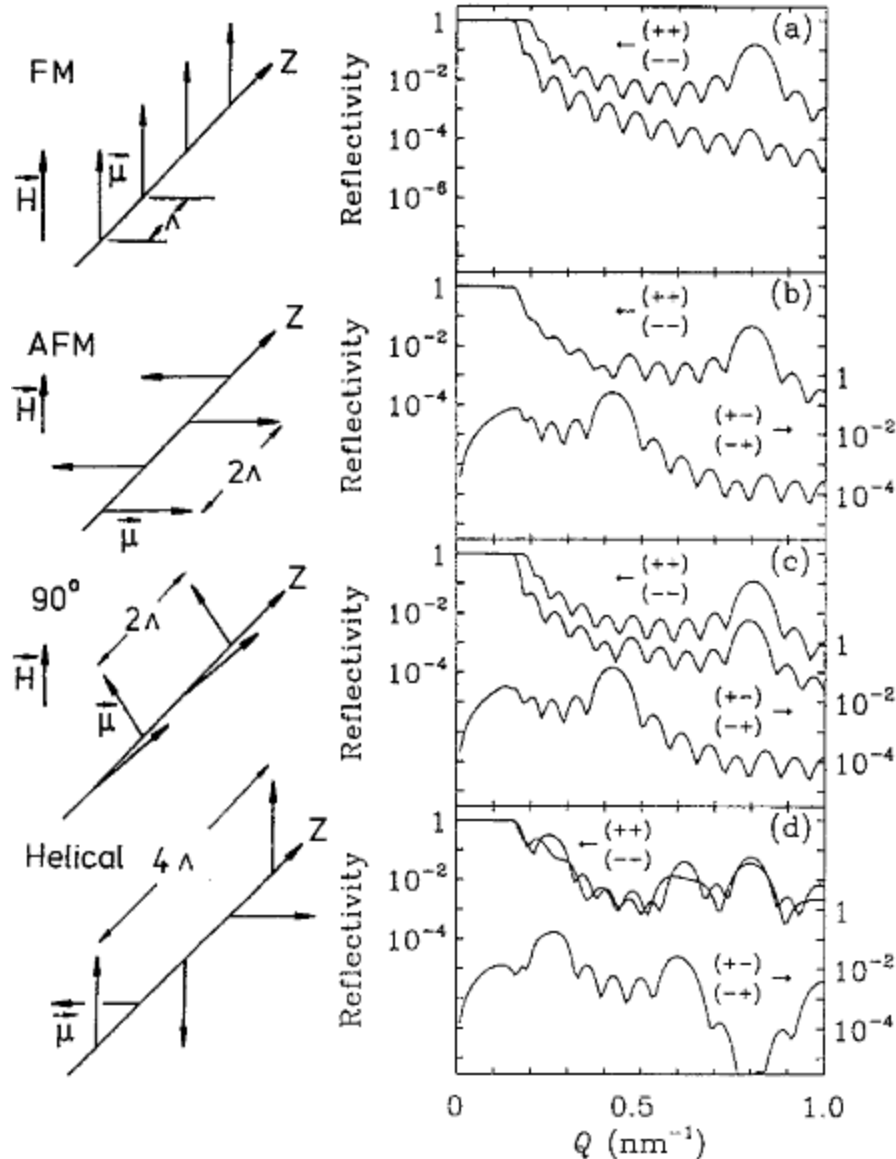
$$[\partial_x^2 + k_{0x}^2 - 4\pi\rho_{--}]\psi_- - 4\pi\rho_{-+}\psi_+ = 0$$

$$\rho_{\pm\pm} = \rho_n \pm \frac{m}{2\pi\hbar^2} \mu B_z ; \quad \rho_{\pm\mp} = \frac{m}{2\pi\hbar^2} \mu (B_x \mp iB_y)$$

Magnetic reflectometry

- ρ_{+-} and ρ_{-+} cause spin flips during scattering
- If \mathbf{B} is parallel to \hat{z} , then the equations decouple and there is no spin flipping. Then we can treat each polarization separately.
- For arbitrary $\mathbf{B}(z)$ we can solve for the reflectivity numerically using an approach similar to the Parratt formalism (Felcher 1987)
- Corrections must be applied for incomplete beam polarization

Magnetic reflectometry



- Simulations: alternating Fe/Cr layers, each 4nm thick. 20 layers total.
- Magnetism only in Fe layers

Non-specular reflection

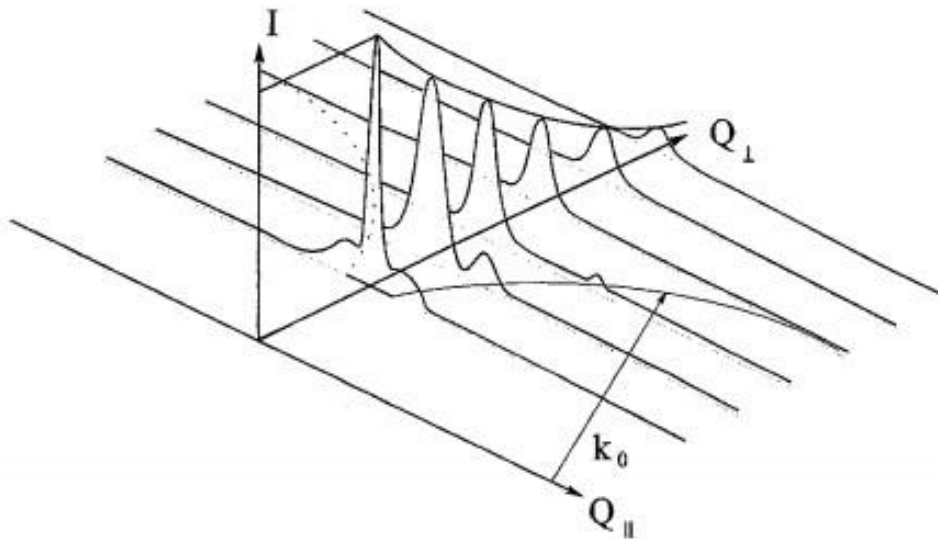


Fig. 7. Schematic view of the specular and off-specular intensity in the reciprocal space parallel to the scattering plane and for a single rough surface. In scans parallel to Q_{\perp} the specular intensity is probed, in the directions parallel to Q_{\parallel} the diffuse intensity from the in-plane roughness is examined. The *circles* indicate the location where the transmission coefficients $|t(\phi)|^2$ have maxima, causing the diffuse scattering to exhibit peaks, so called angle's wings or Yoneda peaks

- Diffuse scattering from interfacial roughness (Sinha 1988)
- Off specular peaks from in-plane order
 - Also Yoneda peaks near the critical angle, where the transmission coefficient is maximized
- Sensitive to components of ***B*** normal to plane

What about x-rays?

- Brighter, more coherent sources
- Element specificity
- Unaffected by external magnetic fields
- Lower penetration depth
- Insensitive to light elements
- Magnetic scattering much weaker than charge scattering

Spallation Neutron Source (ORNL)

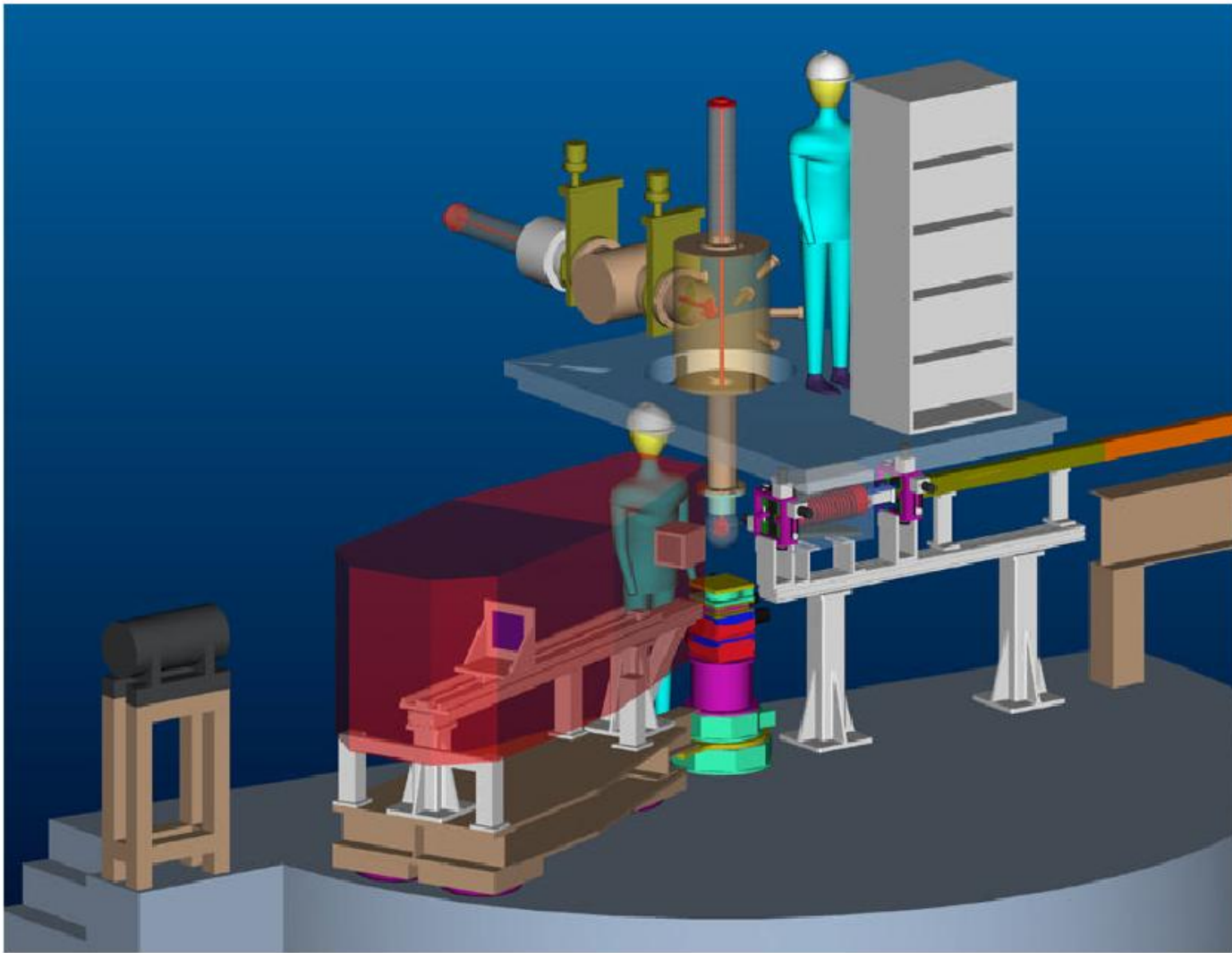
- Proton accelerated into mercury target, neutrons knocked loose
- Neutrons come out in pulses (60 Hz)
- Moderator gives them a thermal distribution of velocities
- Detector uses time of flight methods to determine Q

SNS BL4a Fact Sheet

- Wavelength range: $1.8\text{\AA} < \lambda < 14.0\text{\AA}$
- Q range: $0 < Q < 0.4\text{\AA}^{-1}$
- Minimum reflectivity: 10^{-8}
- Magnetic field max
 - 1.2 T with a gap of 50 mm
 - 3 T with a gap of 10 mm
- Temperature range: $5 - 750\text{ K}$

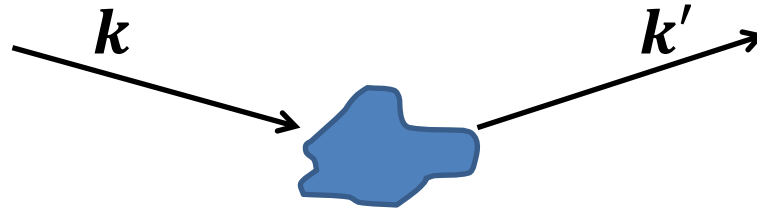
References

- H. Zabel, “X-ray and neutron reflectivity analysis of thin films and superlattices,” *Applied Physics A Solids and Surfaces*, vol. 58, no. 3, pp. 159-168, Mar. 1994.
- C. F. Majkrzak and N. F. Berk, “Exact determination of the phase in neutron reflectometry,” *Physical Review B*, vol. 52, no. 15, p. 10827, Oct. 1995.
- S. K. Sinha, E. B. Sirota, S. Garoff, and H. B. Stanley, “X-ray and neutron scattering from rough surfaces,” *Physical Review B*, vol. 38, no. 4, p. 2297, 1988.
- G. P. Felcher, R. O. Hilleke, R. K. Crawford, J. Haumann, R. Kleb, and G. Ostrowski, “Polarized neutron reflectometer: A new instrument to measure magnetic depth profiles,” *Review of Scientific Instruments*, vol. 58, no. 4, p. 609, 1987.
- Lectures by Majkrzak, Sinha, Pynn



UHV system for in-situ polarized reflectometry experiments on ultrathin magnetic films (for clarity reasons the sample magnet is suppressed).

Scattering from many nuclei



- $\mathbf{q} = \mathbf{k}' - \mathbf{k}$
- $\frac{d\sigma}{d\Omega} = \sum_{ij} b_i b_j e^{i\mathbf{q} \cdot (\mathbf{r}_i - \mathbf{r}_j)}$
- Ensemble average: $\frac{d\sigma}{d\Omega} = \langle b \rangle^2 S(\mathbf{q})$
- $S(\mathbf{q}) = \langle \sum_{ij} e^{i\mathbf{q} \cdot (\mathbf{r}_i - \mathbf{r}_j)} \rangle = \langle \hat{\rho}_n(\mathbf{q}) \hat{\rho}_n^*(\mathbf{q}) \rangle$
- $\hat{\rho}_n(\mathbf{q})$ is the Fourier transform of nuclear density